である 空海SN74CB3Q3305PWRE4供应商 INSTRUMENTS www.ti.com

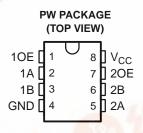
捷多邦,专业PCB打样工厂,24小时加**会**CB3Q3305 DUAL FET BUS SWITCH 2.5-V/3.3-V LOW-VOLTAGE HIGH-BANDWIDTH BUS SWITCH

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FEATURES

- High-Bandwidth Data Path (up to 500 MHz ⁽¹⁾)
- 5-V Tolerant I/Os With Device Powered Up or Powered Down
- Low and Flat ON-State Resistance (r_{on}) Characteristics Over Operating Range (r_{on} = 3 Ω Typ)
- Rail-to-Rail Switching on Data I/O Ports
 0- to 5-V Switching With 3.3-V V_{cc}
 - 0- to 3.3-V Switching With 2.5-V V_{cc}
- Bidirectional Data Flow With Near-Zero
 Propagation Delay
- Low Input/Output Capacitance Minimizes Loading and Signal Distortion (C_{io(OFF)} = 3.5 pF Typ)
- Fast Switching Frequency (f_{OE} = 20 MHz Max)
- For additional information regarding the performance characteristics of the CB3Q family, refer to the TI application report, CBT-C, CB3T, and CB3Q Signal-Switch Families, literature number SCDA008.

- Data and Control Inputs Provide Undershoot Clamp Diodes
- Low Power Consumption (I_{CC} = 0.25 mA Typ)
- V_{CC} Operating Range From 2.3 V to 3.6 V
- Data I/Os Support 0- to 5-V Signaling Levels (0.8 V, 1.2 V, 1.5 V, 1.8 V, 2.5 V, 3.3 V, 5 V)
- Control Inputs Can Be Driven by TTL or 5-V/3.3-V CMOS Outputs
- I_{off} Supports Partial-Power-Down Mode Operation
- Latch-Up Performance Exceeds 100 mA Per JESD 78, Class II
- ESD Performance Tested Per JESD 22
 - 2000-V Human-Body Model (A114-B, Class II)
 - 1000-V Charged-Device Model (C101)
- Supports Both Digital and Analog Applications: USB Interface, Differential Signal Interface, Bus Isolation, Low-Distortion Signal Gating



DESCRIPTION/ORDERING INFORMATION

The SN74CB3Q3305 is a high-bandwidth FET bus switch utilizing a charge pump to elevate the gate voltage of the pass transistor, providing a low and flat ON-state resistance (r_{on}). The low and flat ON-state resistance allows for minimal propagation delay and supports rail-to-rail switching on the data input/output (I/O) ports. The device also features low data I/O capacitance to minimize capacitive loading and signal distortion on the data bus. Specifically designed to support high-bandwidth applications, the SN74CB3Q3305 provides an optimized interface solution ideally suited for broadband communications, networking, and data-intensive computing systems.

The SN74CB3Q3305 is organized as two 1-bit switches with separate output-enable (1OE, 2OE) inputs. It can be used as two 1-bit bus switches or as one 2-bit bus switch. When OE is high, the associated 1-bit bus switch is ON and the A port is connected to the B port, allowing bidirectional data flow between ports. When OE is low, the associated 1-bit bus switch is OFF and a high-impedance state exists between the A and B ports.

ORDERING INFORMATION

T _A PACKAGE ⁽¹⁾		ORDERABLE PART NUMBER	TOP-SIDE MARKING		
-40°C to 85°C	TECOD DW	Tube	SN74CB3Q3305PW	- BU305	
	TSSOP – PW	Tape and reel	SN74CB3Q3305PWR	- BU305	

(1) Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

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PRODUCTION DATA information is current as of publication date Products conform to specifications per the terms of the Texas

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DESCRIPTION/ORDERING INFORMATION (CONTINUED)

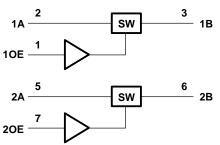
This device is fully specified for partial-power-down applications using I_{off} . The I_{off} circuitry prevents damaging current backflow through the device when it is powered down. The device has isolation during power off.

To ensure the high-impedance state during power up or power down, OE should be tied to GND through a pulldown resistor; the minimum value of the resistor is determined by the current-sourcing capability of the driver.

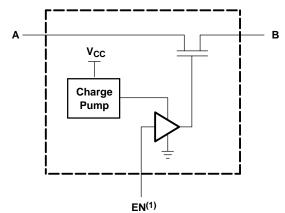
FUNCTION TABLE (EACH BUS SWITCH)

INPUT OE	INPUT/OUTPUT A	FUNCTION
Н	В	A port = B port
L	Z	Disconnect

LOGIC DIAGRAM (POSITIVE LOGIC)



SIMPLIFIED SCHEMATIC, EACH FET SWITCH (SW)



(1) EN is the internal enable signal applied to the switch.



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Absolute Maximum Ratings⁽¹⁾

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
V_{CC}	V _{CC} Supply voltage range				V
V _{IN}	V _{IN} Control input voltage range ⁽²⁾⁽³⁾			7	V
V _{I/O}	V _{I/O} Switch I/O voltage range ⁽²⁾⁽³⁾⁽⁴⁾				V
I _{IK}	Control input clamp current	V _{IN} < 0		-50	mA
I _{I/OK}	I/O port clamp current	V _{I/O} < 0		-50	mA
I _{I/O}	ON-state switch current ⁽⁵⁾			±64	mA
	Continuous current through V_{CC} or GND			±100	mA
θ_{JA}	Package thermal impedance ⁽⁶⁾			88	°C/W
T _{stg}					°C

(1) Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating" conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

All voltages are with respect to ground, unless otherwise specified. (2)

(3) The input and output voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

 V_I and V_O are used to denote specific conditions for $V_{I/O}$. (4)

(5)

 I_I and I_O are used to denote specific conditions for $I_{I/O}$. The package thermal impedance is calculated in accordance with JESD 51-7. (6)

Recommended Operating Conditions⁽¹⁾

			MIN	MAX	UNIT
V _{CC}	Supply voltage			3.6	V
v		V _{CC} = 2.3 V to 2.7 V		5.5	V
VIH	High-level control input voltage	$V_{CC} = 2.7 V \text{ to } 3.6 V$	2	5.5	v
.,	$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$		0	0.7	V
VIL	Low-level control input voltage	$V_{CC} = 2.7 V \text{ to } 3.6 V$	0	0.8	v
V _{I/O}	Data input/output voltage		0	5.5	V
T _A	Operating free-air temperature				°C

All unused control inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, (1) Implications of Slow or Floating CMOS Inputs, literature number SCBA004.



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Electrical Characteristics⁽¹⁾

over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER			TEST CONDITION	S	MIN	TYP ⁽²⁾	MAX	UNIT
V _{IK}		V _{CC} = 3.6 V,	I _I = -18 mA				-1.8	V
I _{IN}	Control inputs	V _{CC} = 3.6 V,	$V_{IN} = 0$ to 5.5 V				±1	μΑ
$I_{OZ}^{(3)}$		V _{CC} = 3.6 V,	$V_{O} = 0$ to 5.5 V, $V_{I} = 0$,	Switch OFF, V _{IN} = V _{CC} or GND			±1	μΑ
I _{off}		V _{CC} = 0,	$V_0 = 0$ to 5.5 V,	V ₁ = 0			1	μA
I _{CC}		V _{CC} = 3.6 V,	l _{l/O} = 0, Switch ON or OFF,	$V_{IN} = V_{CC}$ or GND		0.25	0.7	mA
$\Delta I_{CC}^{(4)}$	Control inputs	V_{CC} = 3.6 V, One inp	ut at 3 V, Other inputs at			25	μΑ	
I _{CCD} ⁽⁵⁾	Per control input	V _{CC} = 3.6 V, Control input switchin	A and B ports open, g at 50% duty cycle		0.040	0.045	mA/ MHz	
C _{in}	Control inputs	V _{CC} = 3.3 V,	V _{IN} = 5.5 V, 3.3 V, or 0			2.5	3.5	pF
Cio(OFF)		V _{CC} = 3.3 V,	Switch OFF, V _{IN} = V _{CC} or GND,	$V_{I/O} = 5.5 V, 3.3 V, \text{ or } 0$		3.5	5	pF
C _{io(ON)}		V _{CC} = 3.3 V,	Switch ON, V _{IN} = V _{CC} or GND,	$V_{I/O} = 5.5 V, 3.3 V, or 0$		8	10.5	pF
		V _{CC} = 2.3 V,	V _I = 0, I _O = 30 mA		3	3	8	
		TYP at $V_{CC} = 2.5 V$	$V_{I} = 1.7 \text{ V}, I_{O} = -15 \text{ mA}$			3.5	9	Ω
r _{on} (6)		V - 2 V	V _I = 0, I _O = 30 mA			3	6	52
		$V_{CC} = 3 V$ $V_{I} = 2.4 V, I_{O} = -15 mA$				3.5	8	

(1)

 V_{IN} and I_{IN} refer to control inputs. $V_{I},\,V_{O},\,I_{I}$, and I_{O} refer to data pins. All typical values are at V_{CC} = 3.3 V (unless otherwise noted), T_{A} = 25°C. For I/O ports, the parameter I_{OZ} includes the input leakage current. (2)

(3)

This is the increase in supply current for each input that is at the specified TTL voltage level, rather than V_{CC} or GND. (4)

(5) This parameter specifies the dynamic power-supply current associated with the operating frequency of a single control input (see Figure 2).

Measured by the voltage drop between the A and B terminals at the indicated current through the switch. ON-state resistance is (6) determined by the lower of the voltages of the two (A or B) terminals.

Switching Characteristics

over recommended operating free-air temperature range (unless otherwise noted) (see Figure 3)

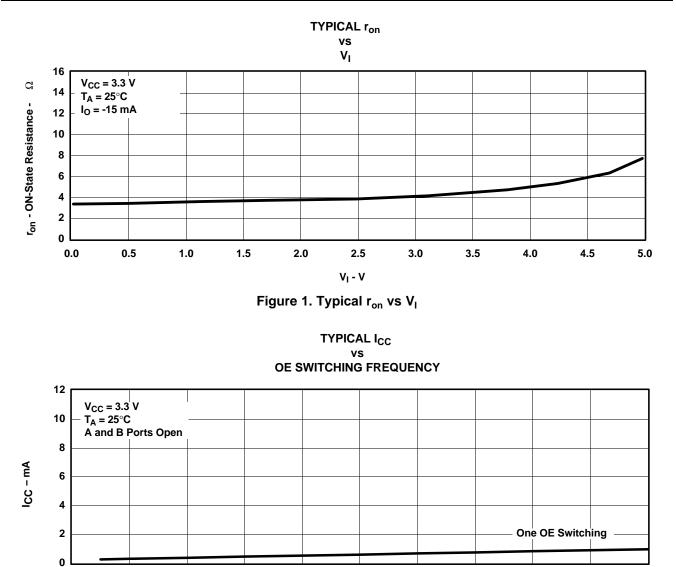
PARAMETER		TO (OUTPUT)	V _{CC} = 2.5 V ± 0.2 V		V _{CC} = 3.3 V ± 0.3 V		UNIT
	(INPUT)	(001F01)	MIN	MAX	MIN	MAX	
f _{OE} ⁽¹⁾	OE	A or B		10		20	MHz
t _{pd} ⁽²⁾	A or B	B or A		0.09		0.15	ns
t _{en}	OE	A or B	1	5	1	4.5	ns
t _{dis}	OE	A or B	1	4.5	1	5	ns

(1)

Maximum switching frequency for control input ($V_O > V_{CC}$, $V_I = 5 V$, $R_L \ge 1 M\Omega$, $C_L = 0$) The propagation delay is the calculated RC time constant of the typical ON-state resistance of the switch and the specified load (2)capacitance, when driven by an ideal voltage source (zero output impedance).



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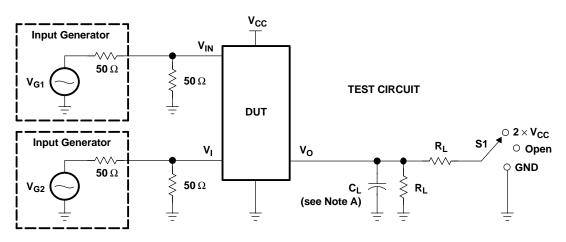
OE Switching Frequency – MHz



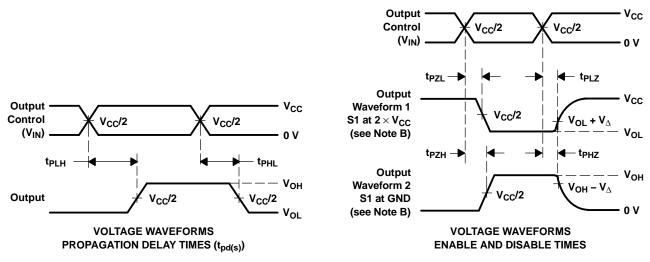
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PARAMETER MEASUREMENT INFORMATION



TEST	V _{CC}	S1	RL	VI	CL	\mathbf{V}_{Δ}
t _{pd(s)}	2.5 V \pm 0.2 V 3.3 V \pm 0.3 V	Open Open	500 Ω 500 Ω	V _{CC} or GND V _{CC} or GND	30 pF 50 pF	
t _{PLZ} /t _{PZL}	$\begin{array}{c} \textbf{2.5 V} \pm \textbf{0.2 V} \\ \textbf{3.3 V} \pm \textbf{0.3 V} \end{array}$	$\begin{array}{c} \textbf{2} \times \textbf{V}_{\textbf{CC}} \\ \textbf{2} \times \textbf{V}_{\textbf{CC}} \end{array}$	500 Ω 500 Ω	GND GND	30 pF 50 pF	0.15 V 0.3 V
t _{PHZ} /t _{PZH}	$\begin{array}{c} \textbf{2.5 V} \pm \textbf{0.2 V} \\ \textbf{3.3 V} \pm \textbf{0.3 V} \end{array}$	GND GND	500 Ω 500 Ω	V _{CC} V _{CC}	30 pF 50 pF	0.15 V 0.3 V



NOTES: A. C_L includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, Z₀ = 50 Ω , t_f \leq 2.5 ns, t_f \leq 2.5 ns.
- D. The outputs are measured one at a time, with one transition per measurement.
- E. t_{PLZ} and t_{PHZ} are the same as $t_{dis}.$
- F. t_{PZL} and t_{PZH} are the same as t_{en} .
- G. t_{PLH} and t_{PHL} are the same as $t_{pd(s)}$. The t_{pd} propagation delay is the calculated RC time constant of the typical ON-state resistance of the switch and the specified load capacitance, when driven by an ideal voltage source (zero output impedance).
- H. All parameters and waveforms are not applicable to all devices.

Figure 3. Test Circuit and Voltage Waveforms



PACKAGE OPTION ADDENDUM

8-Aug-2005

PACKAGING INFORMATION

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins	Package Qty	Eco Plan ⁽²⁾	Lead/Ball Finish	MSL Peak Temp ⁽³⁾
74CB3Q3305DCURE4	ACTIVE	US8	DCU	8	3000	Pb-Free (RoHS)	CU NIPDAU	Level-1-260C-UNLIM
SN74CB3Q3305DCUR	ACTIVE	US8	DCU	8	3000	Pb-Free (RoHS)	CU NIPDAU	Level-1-260C-UNLIM
SN74CB3Q3305PW	ACTIVE	TSSOP	PW	8	150	Green (RoHS 8 no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74CB3Q3305PWE4	ACTIVE	TSSOP	PW	8	150	Green (RoHS 8 no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74CB3Q3305PWR	ACTIVE	TSSOP	PW	8	2000	Green (RoHS 8 no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74CB3Q3305PWRE4	ACTIVE	TSSOP	PW	8	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS) or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details. TBD: The Pb-Free/Green conversion plan has not been defined.

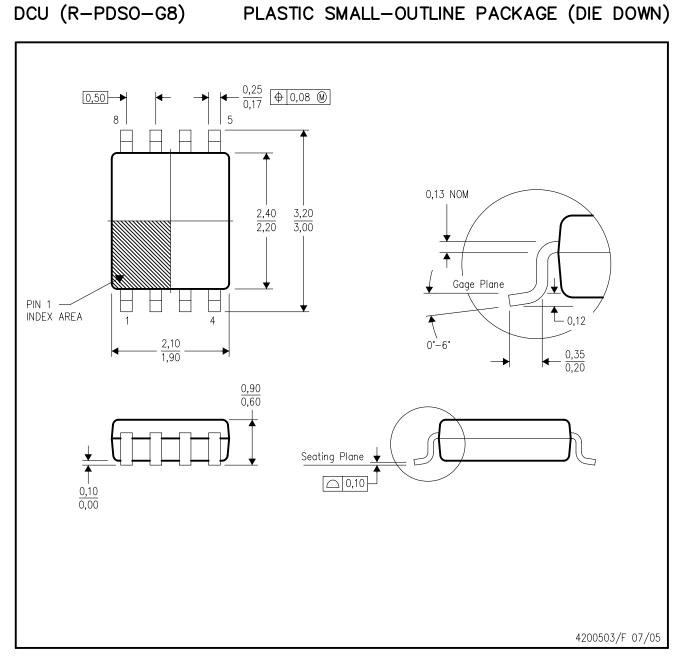
Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

⁽³⁾ MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion. Mold flash and protrusion shall not exceed 0.15 per side.
- D. Falls within JEDEC MO-187 variation CA.



MECHANICAL DATA

MTSS001C - JANUARY 1995 - REVISED FEBRUARY 1999

PLASTIC SMALL-OUTLINE PACKAGE





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